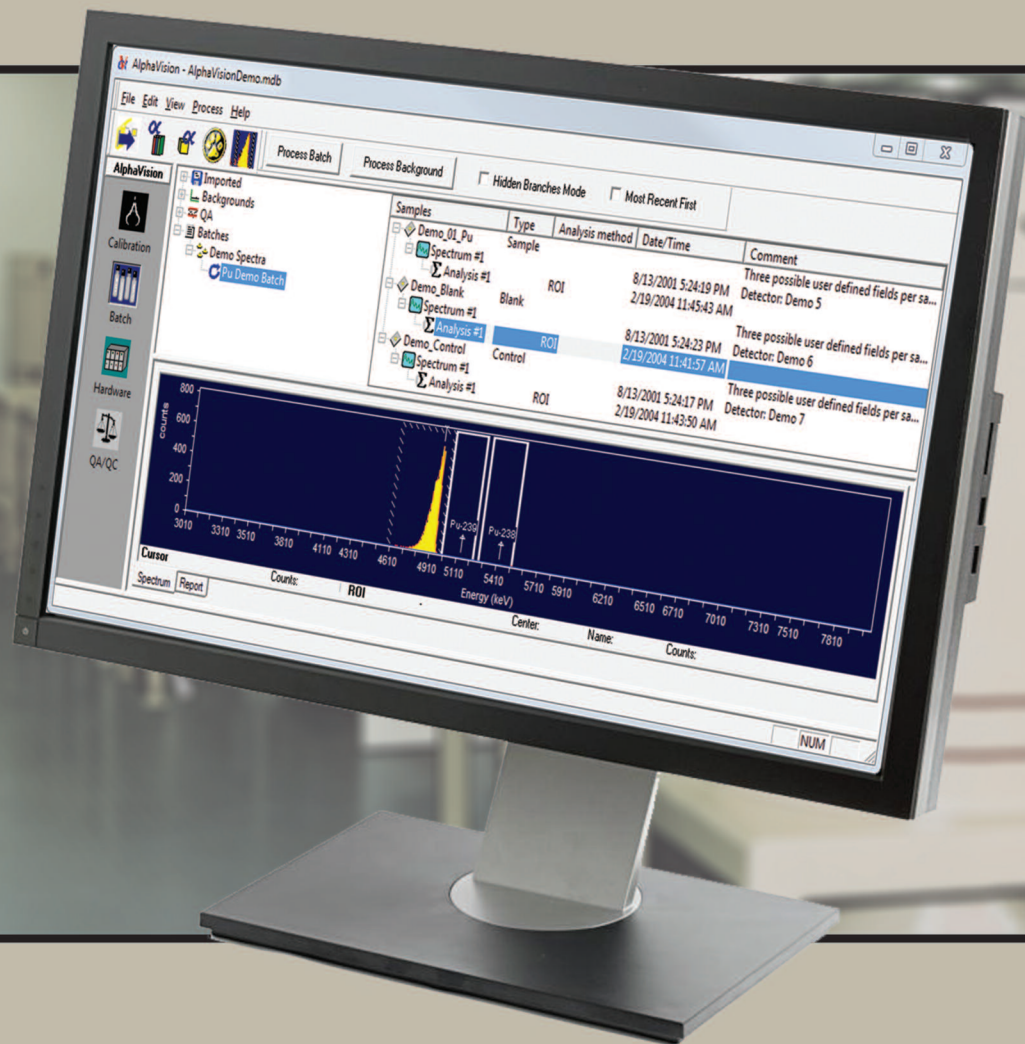


# ORTEC®

## AlphaVision®

Alpha Spectrometry Management Software



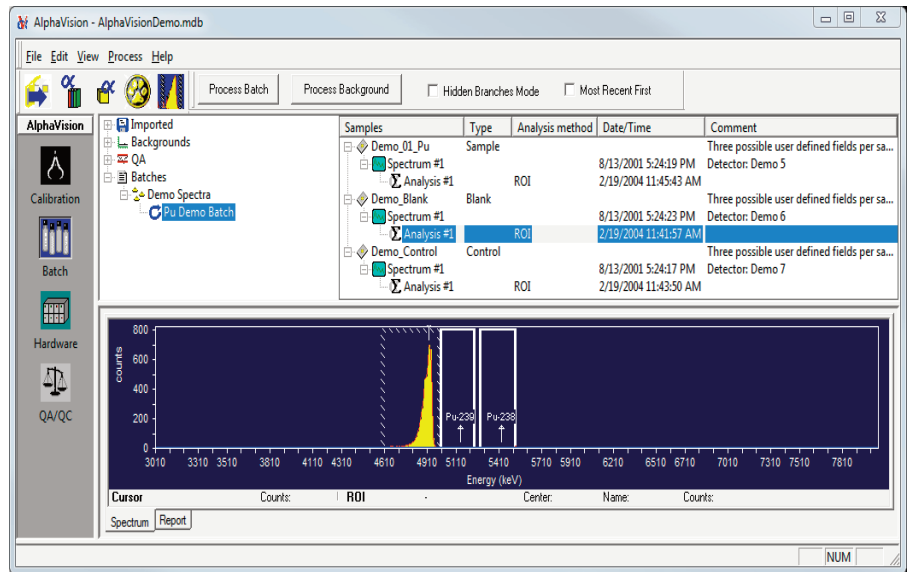
“The Comprehensive Alpha Spectrometry Solution for Compatible, Efficient, and Defendable Alpha Measurements.”

**AMETEK®**  
ADVANCED MEASUREMENT TECHNOLOGY

# AlphaVision

AlphaVision is a comprehensive PC-based alpha spectrometry application that combines rich features and intuitive processes to meet the demands of modern Radiochemistry Laboratories.

In large scale commercial laboratories with hundreds of alpha detectors or small labs with only a few detectors, AlphaVision is your solution to optimize routine measurement processes and monitor system performance.



## Why AlphaVision?

### Compatibility

- Windows 10 64-bit Compatible.
- Microsoft Access Database with Data Management tools and LIMS integration capability.
- Crystal Reports integration for Rich Standard Reports and Custom Report capability.
- Extensive Analysis capability to accommodate a wide variety of Radiochemistry processes.

### Process Efficiency

- Batch Configuration process with LIMS<sup>1</sup> integration to maximize throughput and minimize errors.
- Intuitive Sample Management including Query tools to quickly locate Batches and Samples.
- Rapid Data Review and Analysis modification process.
- Integrated Hardware control for up to 256 detectors in a common interface.

### Defendable Results

- Security controls to limit user access to authorized functions.
- Compliance with Industry Standards such as ANSI N13.30 and N42.23.
- Comprehensive Quality Control features.
- Historical Analysis retention when re-analyzing samples.
- Detailed Event Logging for routine operations, warnings, and errors.

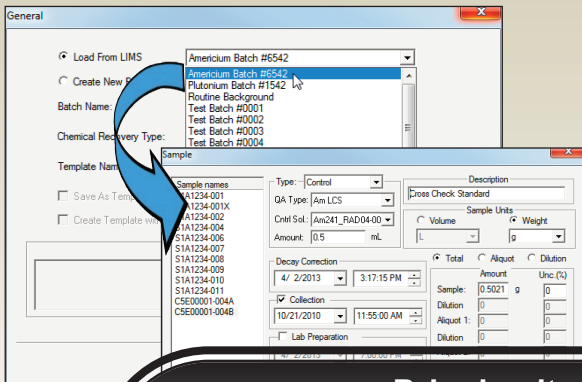
## Introducing AlphaVision 7.0!

- New!** 64-Bit Windows 10 Compatibility.
- New!** Alpha Mega now supported in the Instrument Group Control.<sup>2</sup>
- New!** Automatic Spectrum Export on Completion of Calibration Measurements.
- New!** Simple Spectrum Export from any spectrum window.
- New!** Notification of Communication Interruption on the Instrument Group Control.<sup>2</sup>

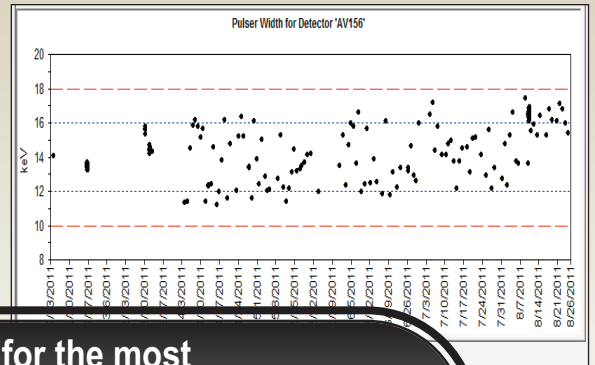
<sup>1</sup> Laboratory Information Management System.

<sup>2</sup> Hardware control is available for instruments with software control capability.

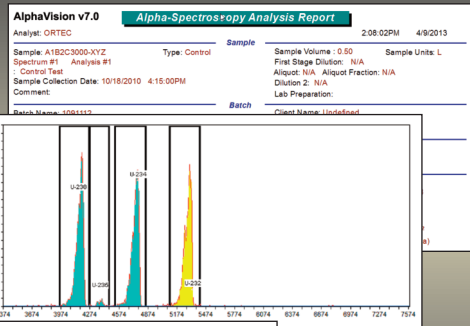
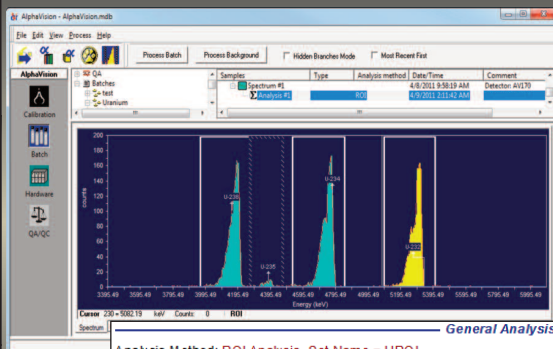
## Batch Automation



## Quality Assurance



Bringing it all together for the most Compatible, Efficient, and Defendable Results Possible!

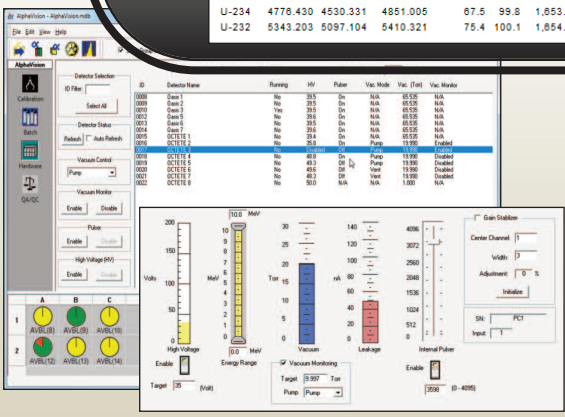


Analysis Method: ROI Analysis, Set Name = UROI  
 Decay Correction: 4/7/2011 3:26:52PM  
 MDA Constants:  $K_{\alpha} = 1.64$ ,  $K_{\beta} = 1.64$

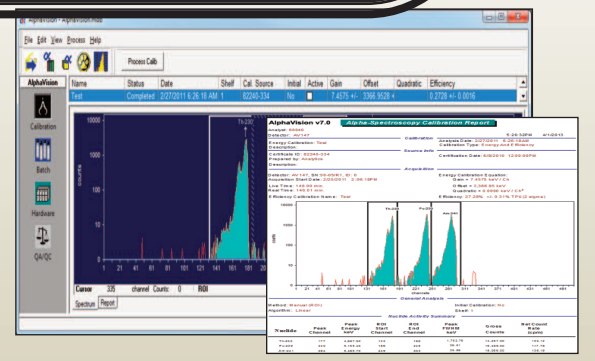
Nuclide Library: Uranium  
 MDA Source: Background

Nuclide Summary (ROI)

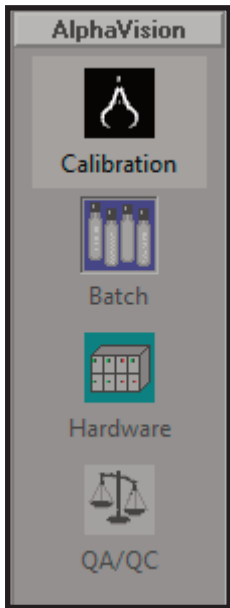
Nuclide	Peak Energy keV	ROI Start keV	ROI End keV	FWHM keV	B.R. %	Gross Counts	Bkgd Counts	Net Counts	Activity pCi/L	1.00Sigma TPU pCi/L	Critical Level pCi/L	MDA pCi/L
U-238	4157.453	3956.099	4261.858	70.9	100.0	1,777.00	0.0000	6,959E+000	4.274E-001	0.000E+000	1.060E-002	
U-235	4381.179	4269.316	4470.670	67.9	80.2	59.00	0.0000	2.881E-001	4.109E-002	0.000E+000	1.321E-002	
U-234	4776.430	4530.331	4851.005	67.5	99.8	1,853.00	0.8000	1652.20	6.483E+000	4.004E-001	7.748E-003	2.611E-002
U-232	5343.203	5097.104	5410.321	75.4	100.1	1,854.00	2.4000	1651.80	6.110E+000	3.437E-001	1.445E-002	4.033E-002



## Hardware Control

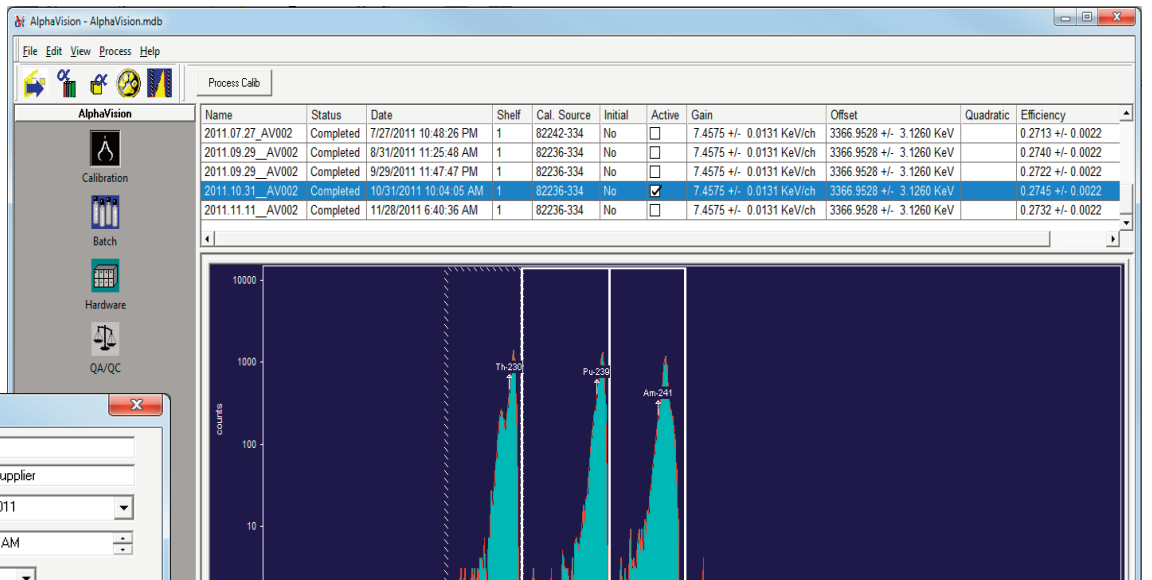


## Calibration



## Calibration

- α Energy and Efficiency Calibration
- α Automated and Interactive Peak Fit
- α Traceable Historical Calibration Records
- α Active/Deactivate Calibrations
- α Customizable Calibration Report
- α Unlimited Calibration Standards



Calibration Source: STD-123

Certificate ID:

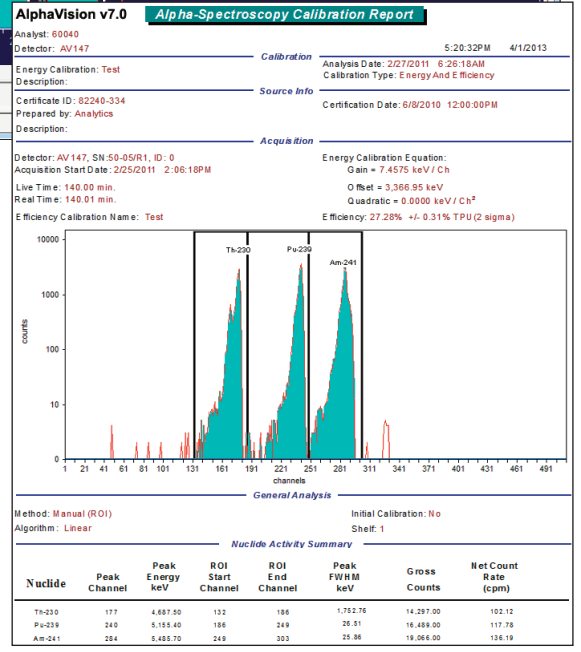
Manufacturer:

Certification:

Source Activity Units:

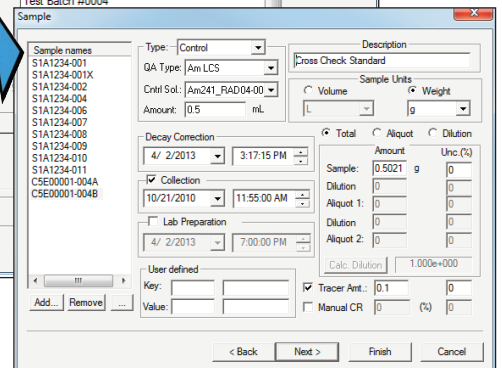
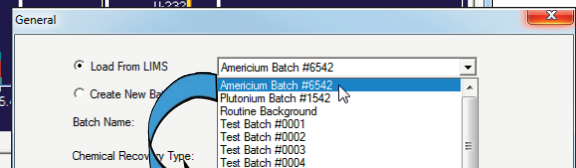
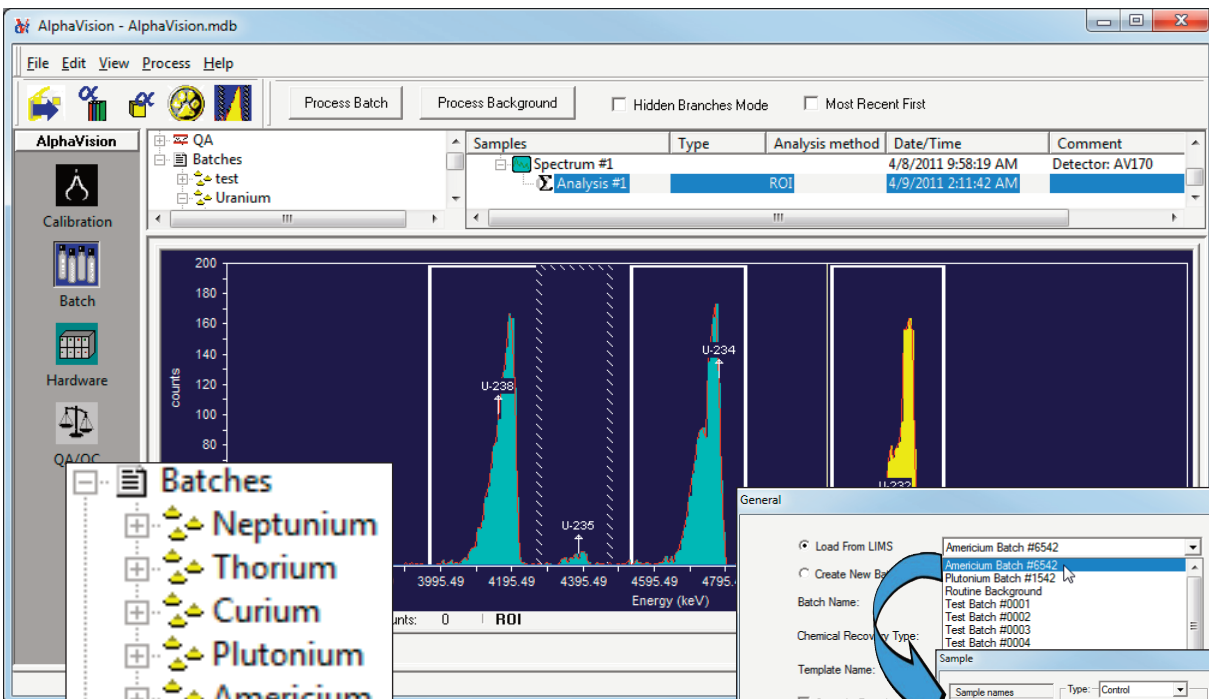
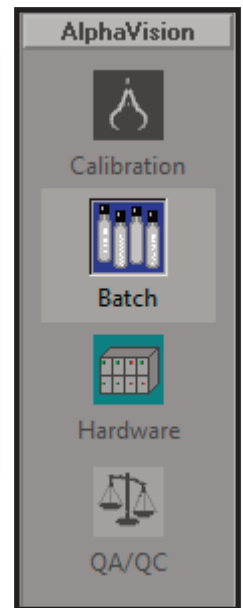
Name	Activity (DPM)
Th-230	410.0000
Pu-239	330.0000
Am-241	330.0000

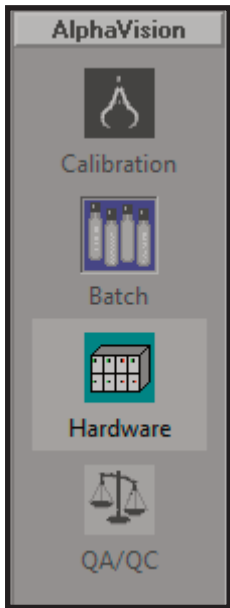
Buttons: Add..., Edit..., Remove, OK, Cancel



## Batch Automation

- α Analysis Templates for Consistent Processes
- α LIMS Integration Capability
- α Extensive Analysis Options for Peak Fit, Activity Calculations including Tracer and Dilution Schemes, and Detection Limits
- α Custom Reports with Crystal Reports 11.5
- α True "Count to MDA" Presets
- α Interactive Review/Reanalysis





## Hardware Control

- α Rapid Detector “Group” Operations
- α Integrated Instrument Control Based on Instrument Type
- α Detector Status Indicators “at a glance”
- α Automated Instrument Setup
- α Configurable Detector Grid

The screenshot displays the AlphaVision software interface. At the top, there is a menu bar (File, Edit, View, Help) and a toolbar with various icons. Below the toolbar, there are control panels for Detector Selection, Detector Status, Vacuum Control, Vacuum Monitor, Pulser, and High Voltage (HV). The main area features a table of detector status:

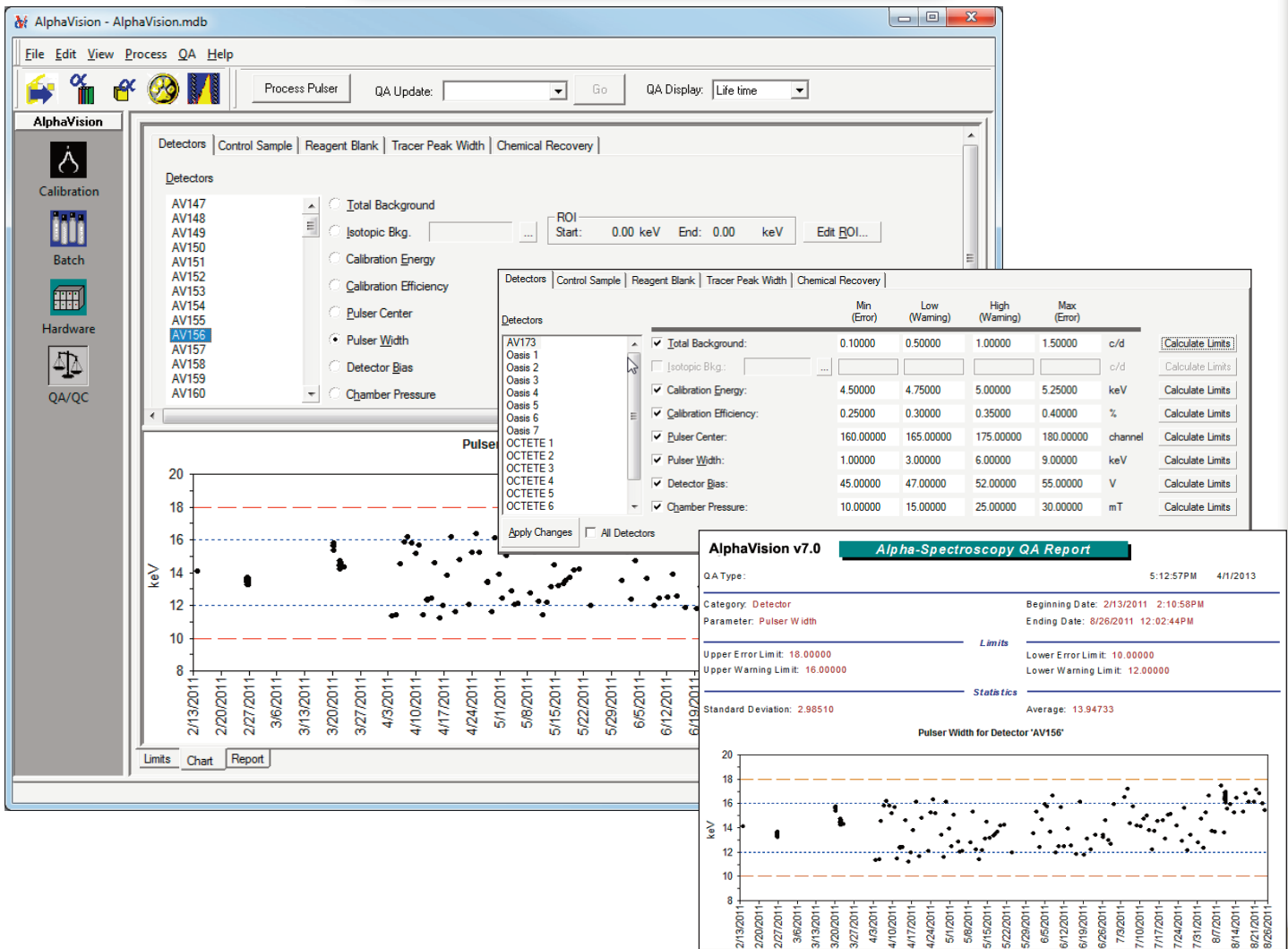
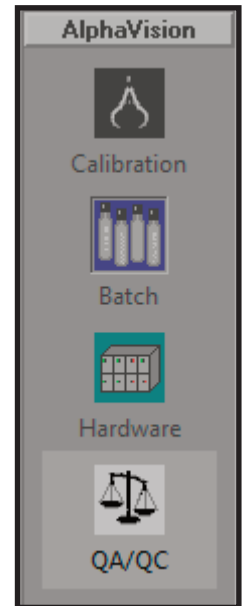
ID	Detector Name	Running	HV	Pulser	Vac. Mode	Vac. (Torr)	Vac. Monitor
0008	Oasis 1	No	39.5	On	N/A	65.535	N/A
0009	Oasis 2	No	39.5	On	N/A	65.535	N/A
0010	Oasis 3	Yes	39.5	On	N/A	65.535	N/A
0012	Oasis 5	No	39.6	On	N/A	65.535	N/A
0013	Oasis 6	No	39.5	On	N/A	65.535	N/A
0014	Oasis 7	No	39.6	On	N/A	65.535	N/A
0015	OCTETE 1	No	39.4	On	N/A	65.535	N/A
0016	OCTETE 2	No	35.8	On	Pump	19.990	Enabled
0017	OCTETE 3	No	Disabled	Off	Pump	19.990	Enabled
0018	OCTETE 4	No	48.8	On	Pump	19.990	Disabled
0019	OCTETE 5	No	49.3	Off	Pump	19.990	Disabled
0020	OCTETE 6	No	48.6	Off	Vent	19.990	Disabled
0021	OCTETE 7	No				19.990	Disabled
0022	OCTETE 8	No				19.990	Disabled

Below the table is a detector grid with columns A-H and rows 1-2. Each cell contains a circular status indicator and a label (e.g., AVBL(8) to AVBL(21)). A detailed control panel for the selected detector (OCTETE 3) is overlaid, showing various parameters and controls:

- High Voltage (HV):** Target 35 (Volts), Enable/Disable buttons.
- Vacuum:** Target 9.997 Torr, Pump selection, Vacuum Monitoring checkbox.
- Pulser:** Enable/Disable buttons.
- Energy Range:** 0.0 to 10.0 MeV.
- Leakage:** 0 to 140 nA.
- Internal Pulser:** Target 3598 (0 - 4095), Enable/Disable buttons.
- Gain Stabilizer:** Center Channel 1, Width 3, Adjustment 0%, Initialize button.

## Quality Assurance

- α ANSI N42.23 and ANSI N13.30 Compliant
- α Automated Control Charts and Reports
- α Warning/Alarm Limit Calculations
- α Monitoring Parameters:
  - √ Detector Background (Total and Isotopic)
  - √ Calibration Energy and Efficiency
  - √ Pulser Centroid and Width
  - √ Detector Bias and Chamber Pressure
  - √ Reagent Blank Nuclide Activity
  - √ Control Sample Nuclide Activity
  - √ Tracer Peak Width
  - √ Chemical Recovery



# AlphaVision

## Specifications

<b>Operating System Requirements</b>	Windows 10 64-bit.
<b>Supported Hardware</b>	<p>ORTEC Alpha Suite integrated spectrometers (Alpha Aria, Duo, Ensemble, and Mega) are recommended in order to take advantage of the software controlled operations and Windows 10 64-bit USB connectivity.</p> <p>Legacy instrumentation compatible with ORTEC CONNECTIONS such as ORTEC OCTÊTE-PC, OCTÊTEPlus, 576A, Soloist, 920 series, and Oxford OASIS, as well as the ORTEC 676 Alpha King, Tennelec TC-256, and Canberra 7401/7404 models which are supported through ORTEC MCBs may be available through networked connection to computers running compatible Operating Systems or using the DPM-USB for native Windows 10 compatibility if supported. Contact your local ORTEC representative for questions related to legacy instrument compatibility.</p>
<b>Analysis Methodology</b>	<ul style="list-style-type: none"><li>• Peak Search/Fit Methods: Second Derivative (Mariscotti)<sup>3</sup>, Top Hat Correlation<sup>4</sup>, Peak Interference Correction, ROI (Regions of Interest) including automatic shift of ROIs based on the Tracer Peak, Best Peak, or All Peak positions, and Interactive ROI Adjustment to optimize peak fit during reanalysis.</li><li>• Nuclide Activity Calculations: Absolute (no Tracer), Tracer Recovery Correction, Chemical Recovery Correction (Automatic and Manual), Background Subtraction, Blank Subtraction, Total Propagated Uncertainty.</li><li>• MDA Methods: KTA, Currie, ANSI N13.30, (corrections such as dilution scaling, tracer and chemical recovery, etc. included).</li><li>• Presets: Real and Live Time, Tracer Peak Area, MDA.</li></ul>
<b>System Management</b>	<ul style="list-style-type: none"><li>• Select, Archive, and Compact Database.</li><li>• Search Samples by Batch/Sample ID or Batch Tree Navigation.</li><li>• Event Log captures process information, warnings, and errors.</li><li>• Purge Data.</li><li>• Security:<ul style="list-style-type: none"><li>• Configuration – Save Batch Template, Edit Sample Properties and Client Info, Edit Master Nuclide Library, Nuclide Libraries, Standards, Tracers, and ROIs.</li><li>• Detector Management – Add, Remove, Configure, Move, Edit Properties, Calibrate, Edit Chamber Pressure and Leakage Current Thresholds.</li><li>• Quality Assurance – Edit QA Types and Limits.</li><li>• System – View and Clear Event Log, Edit Batch Tree, Edit Users and Security Levels.</li></ul></li></ul>

## Ordering Information

Model	Description
<b>A36-BW</b>	AlphaVision Alpha Spectrometry Management Software for Windows. Includes standalone or first network copy and binary use license.
<b>A36-BVW</b>	AlphaVision software (A36-BW) with V&V Test Results and Certificate of Validation (A36-VW).
<b>A36-NW</b>	Single Use Network Copy. Requires current version of AlphaVision. Example: For a three-station network, order one copy of A36-BW and two copies of A36-NW.
<b>A36-UW</b>	Update from A36-B32, A36-BW, or A36-NW to latest version of AlphaVision.
<b>A36-UVW</b>	AlphaVision software update (A36-UW) with V&V Test Results and Certificate of Validation (A36-VW).
<b>A36-GW</b>	Additional Hard Copy Documentation for AlphaVision.
<b>A36-VW</b>	AlphaVision V&V Test Results and Certificate of Validation.

<sup>3</sup>M.A. Mariscotti. "A Method for Automatic Identification of Peaks in the Presence of Background and its Application to Spectrum Analysis," Nuclear Instruments and Methods 50, 309–320 (1967).

<sup>4</sup>K. Debertin and R.G. Helmer. Gamma- and X-Ray Spectrometry with Semiconductor Detectors, Elsevier Science, 1988. (If peak shapes are well-controlled (through good sample preparation) the Top-Hat method is likely to yield better results than the Mariscotti method in which peak width is a free parameter.)

Specifications subject to change  
051321